

# DATA SHEET

**74F86**

Quad 2-input exclusive-OR gate

Product specification

1990 Feb 09

IC15 Data Handbook

Quad 2-input Exclusive-OR gate

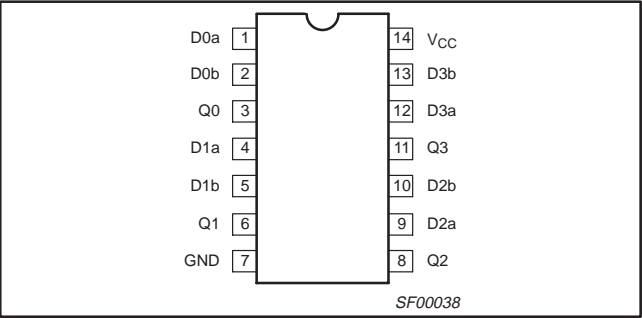
74F86

FEATURE

- Industrial temperature range available (−40°C to +85°C)

TYPE	TYPICAL PROPAGATION DELAY	TYPICAL SUPPLY CURRENT (TOTAL)
74F86	4.3ns	16.5mA

PIN CONFIGURATION



ORDERING INFORMATION

DESCRIPTION	ORDER CODE		PKG DWG #
	COMMERCIAL RANGE $V_{CC} = 5V \pm 10\%$ , $T_{amb} = 0^{\circ}C$ to $+70^{\circ}C$	INDUSTRIAL RANGE $V_{CC} = 5V \pm 10\%$ , $T_{amb} = -40^{\circ}C$ to $+85^{\circ}C$	
14-pin plastic DIP	N74F86N	I74F86N	SOT27-1
14-pin plastic SO	N74F86D	I74F86D	SOT108-1

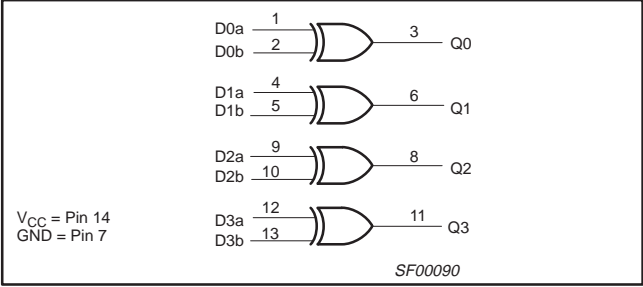
INPUT AND OUTPUT LOADING AND FAN-OUT TABLE

PINS	DESCRIPTION	74F (U.L.) HIGH/LOW	LOAD VALUE HIGH/LOW
Dna, Dnb	Data inputs	1.0/1.0	20μA/0.6mA
Qn	Data output	50/33	1.0mA/20mA

NOTE:

1. One (1.0) FAST unit load is defined as: 20μA in the High state and 0.6mA in the Low state.

LOGIC DIAGRAM



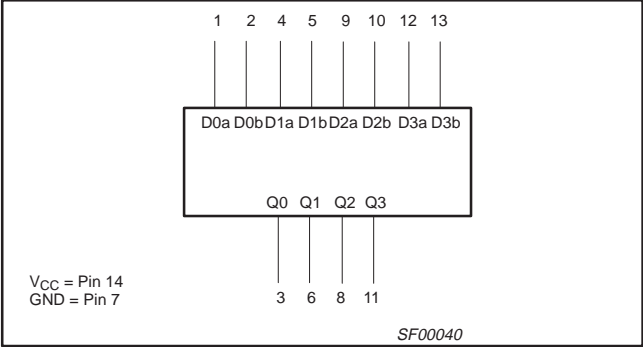
FUNCTION TABLE

INPUTS		OUTPUT
Dna	Dnb	Qn
L	L	L
L	H	H
H	L	H
H	H	L

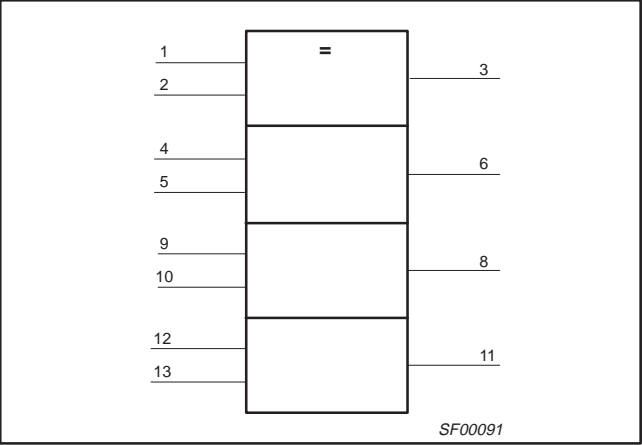
NOTES:

- H = High voltage level  
L = Low voltage level

LOGIC SYMBOL



IEC/IEEE SYMBOL



## Quad 2-input Exclusive-OR gate

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## ABSOLUTE MAXIMUM RATINGS

(Operation beyond the limits set forth in this table may impair the useful life of the device.  
Unless otherwise noted these limits are over the operating free-air temperature range.)

SYMBOL	PARAMETER		RATING	UNIT
$V_{CC}$	Supply voltage		-0.5 to +7.0	V
$V_{IN}$	Input voltage		-0.5 to +7.0	V
$I_{IN}$	Input current		-30 to +5	mA
$V_{OUT}$	Voltage applied to output in High output state		-0.5 to $V_{CC}$	V
$I_{OUT}$	Current applied to output in Low output state		40	mA
$T_{amb}$	Operating free-air temperature range	Commercial range	0 to +70	°C
		Industrial range	-40 to +85	°C
$T_{stg}$	Storage temperature range		-65 to +150	°C

## RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER	LIMITS			UNIT
		MIN	NOM	MAX	
$V_{CC}$	Supply voltage	4.5	5.0	5.5	V
$V_{IH}$	High-level input voltage	2.0			V
$V_{IL}$	Low-level input voltage			0.8	V
$I_{IK}$	Input clamp current			-18	mA
$I_{OH}$	High-level output current			-1	mA
$I_{OL}$	Low-level output current			20	mA
$T_{amb}$	Operating free-air temperature range	Commercial range	0	+70	°C
		Industrial range	-40	+85	°C

## DC ELECTRICAL CHARACTERISTICS

(Over recommended operating free-air temperature range unless otherwise noted.)

SYMBOL	PARAMETER	TEST CONDITIONS <sup>1</sup>		LIMITS			UNIT
				MIN	TYP <sup>2</sup>	MAX	
$V_{OH}$	High-level output voltage	$V_{CC} = \text{MIN}, V_{IL} = \text{MAX}$	$\pm 10\%V_{CC}$	2.5			V
		$V_{IH} = \text{MIN}, I_{OH} = \text{MAX}$	$\pm 5\%V_{CC}$	2.7	3.4		V
$V_{OL}$	Low-level output voltage	$V_{CC} = \text{MIN}, V_{IL} = \text{MAX}$	$\pm 10\%V_{CC}$		0.30	0.50	V
		$V_{IH} = \text{MIN}, I_{OL} = \text{MAX}$	$\pm 5\%V_{CC}$		0.30	0.50	V
$V_{IK}$	Input clamp voltage	$V_{CC} = \text{MIN}, I_I = I_{IK}$			-0.73	-1.2	V
$I_I$	Input current at maximum input voltage	$V_{CC} = \text{MAX}, V_I = 7.0\text{V}$				100	$\mu\text{A}$
$I_{IH}$	High-level input current	$V_{CC} = \text{MAX}, V_I = 2.7\text{V}$				20	$\mu\text{A}$
$I_{IL}$	Low-level input current	$V_{CC} = \text{MAX}, V_I = 0.5\text{V}$				-0.6	mA
$I_{OS}$	Short-circuit output current <sup>3</sup>	$V_{CC} = \text{MAX}$		-60		-150	mA
$I_{CC}$	Supply current (total)	$I_{CCH}$ $V_{CC} = \text{MAX}$	D0a = GND, D0b = 4.5V		15	23	mA
		$I_{CCL}$ $V_{CC} = \text{MAX}$	$V_{IN} = 4.5\text{V}$		18	28	mA

## NOTES:

- For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable type.
- All typical values are at  $V_{CC} = 5\text{V}$ ,  $T_{amb} = 25^\circ\text{C}$ .
- Not more than one output should be shorted at a time. For testing  $I_{OS}$ , the use of high-speed test apparatus and/or sample-and-hold techniques are preferable in order to minimize internal heating and more accurately reflect operational values. Otherwise, prolonged shorting of a High output may raise the chip temperature well above normal and thereby cause invalid readings in other parameter tests. In any sequence of parameter tests,  $I_{OS}$  tests should be performed last.

Quad 2-input Exclusive-OR gate

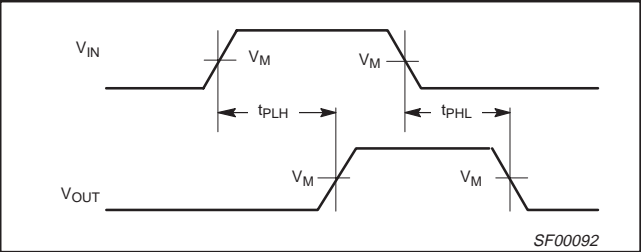
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AC ELECTRICAL CHARACTERISTICS

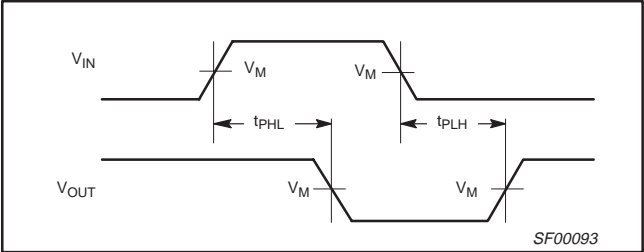
SYMBOL	PARAMETER	TEST CONDITION	LIMITS								UNIT
			$V_{CC} = +5.0V$ $T_{amb} = +25^{\circ}C$ $C_L = 50pF$ $R_L = 500\Omega$			$V_{CC} = +5.0V \pm 10\%$ $T_{amb} = 0^{\circ}C \text{ to } +70^{\circ}C$ $C_L = 50pF$ $R_L = 500\Omega$		$V_{CC} = +5.0V \pm 10\%$ $T_{amb} = -40^{\circ}C \text{ to } +85^{\circ}C$ $C_L = 50pF$ $R_L = 500\Omega$			
			MIN	TYP	MAX	MIN	MAX	MIN	MAX		
$t_{PLH}$ $t_{PHL}$	Propagation delay Dna or Dnb to Qn (other input Low)	Waveform 1	3.0 3.0	4.0 4.2	5.5 5.5	3.0 3.0	6.5 6.5	3.0 2.5	7.0 8.0	ns	
$t_{PLH}$ $t_{PHL}$	Propagation delay Dna or Dnb to Qn (other input High)	Waveform 2	3.5 3.0	5.3 4.7	7.0 6.5	3.5 3.0	8.0 7.5	3.5 3.0	10.0 8.0	ns	

AC WAVEFORMS

For all waveforms,  $V_M = 1.5V$ .



Waveform 1. Propagation Delay for Non-Inverting Outputs



Waveform 2. Propagation Delay for Inverting Outputs

TEST CIRCUIT AND WAVEFORMS

**DEFINITIONS:**

$R_L$  = Load resistor; see AC ELECTRICAL CHARACTERISTICS for value.

$C_L$  = Load capacitance includes jig and probe capacitance; see AC ELECTRICAL CHARACTERISTICS for value.

$R_T$  = Termination resistance should be equal to  $Z_{OUT}$  of pulse generators.

**Input Pulse Definition**

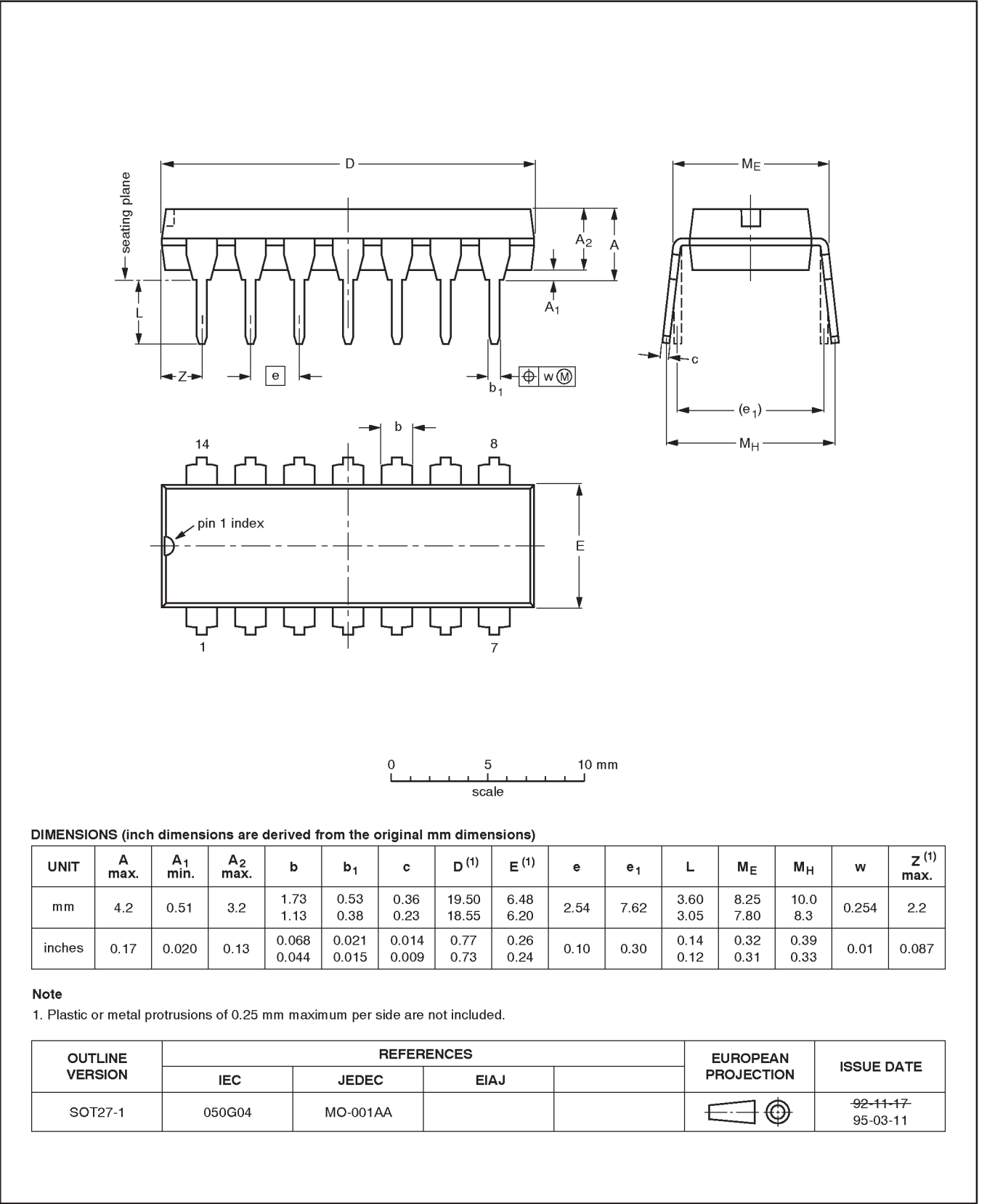
family	INPUT PULSE REQUIREMENTS					
	amplitude	$V_M$	rep. rate	$t_w$	$t_{THL}(t_r)$	$t_{TLH}(t_f)$
74F	3.0V	1.5V	1MHz	500ns	2.5ns	2.5ns

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DIP14: plastic dual in-line package; 14 leads (300 mil)

SOT27-1

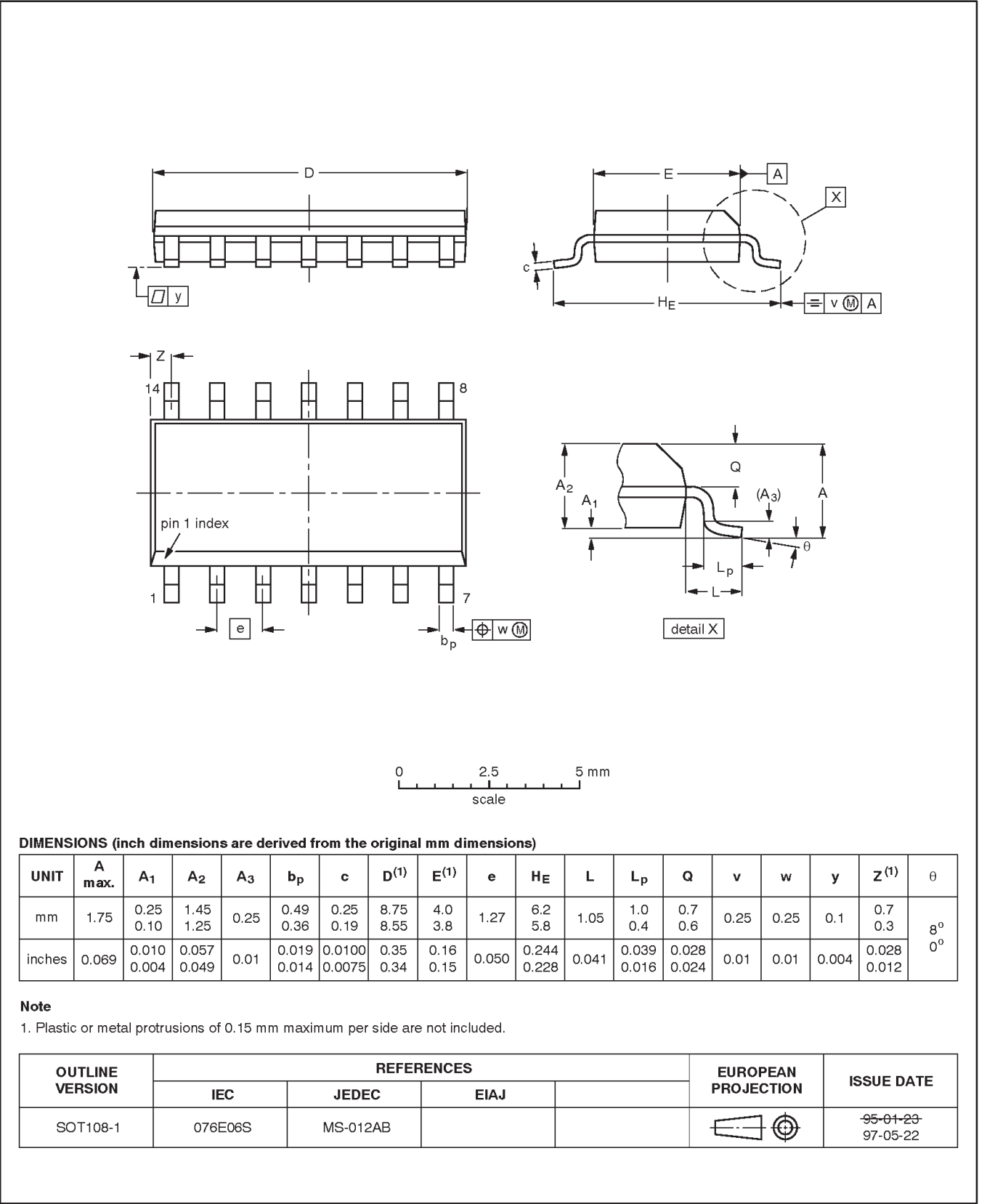


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SO14: plastic small outline package; 14 leads; body width 3.9 mm

SOT108-1



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**NOTES**

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## Data sheet status

Data sheet status	Product status	Definition [1]
Objective specification	Development	This data sheet contains the design target or goal specifications for product development. Specification may change in any manner without notice.
Preliminary specification	Qualification	This data sheet contains preliminary data, and supplementary data will be published at a later date. Philips Semiconductors reserves the right to make changes at any time without notice in order to improve design and supply the best possible product.
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[1] Please consult the most recently issued datasheet before initiating or completing a design.

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**Limiting values definition** — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

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